

THE DRAWING AMENDMENT

Figure 1 is amended to add the legend “Prior Art”.

A marked up version of Figure 1 including the proposed amendment is found at Appendix C of this Reply.

A “Replacement Sheet” including a clean copy of amended Figure 1 is attached at Appendix D of this Reply.

REMARKS

Claims 1, 3-4, 9-10, 13, and 15-19 are pending in the application.

Claims 6, 11-12 and 14 are cancelled from the application without prejudice.

Claim 1 is amended to further distinguish the claimed invention from the prior art.

Claims 3-4, 10, 15, 17 and 19 are amended for a variety of reasons including to alter claim dependency, to correct typographical errors and/or to cause the claim to conform with amended claim 1.

The Abstract is amended above to overcome the examiner's objection.

The specification is amended to correct minor drawing designation errors.

Figure 1 is amended to include the legend "Prior Art".

No new matter has been added to the application by way of these specification and claim amendments.

I. THE ABSTRACT AND SPECIFICATION OBJECTIONS

The examiner objected to the Abstract for including legal phraseology. The Abstract is amended above to remove the objectionable language.

The examiner identified several drawing designation errors in the specification. The examiner also required the submission of a new specification copy that includes the missing text at the bottom of pages 4, 6 and 7. Attached at Appendix A is a marked up copy of the specification. Attached at Appendix B is a clean copy of the amended specification.

II. THE DRAWING OBJECTION

The examiner objected to Figure 1 because it does not include the legend "Prior Art". Figure 1 is amended herein to include the legend "Prior Art". Acceptance of amended Figure 1 is courteously solicited.

III. THE SECTION 112, SECOND PARAGRAPH REJECTION

The examiner rejected claims 4, 6, 10 and 17 under the second paragraph of section 112 for being indefinite.

The rejection of claim 4 is overcome by correcting the claim dependency.

The rejection of claim 6 is moot as claim 6 stands cancelled from the application.

The rejection of claim 10 is overcome by deleting the term “focal” the claim and defining the term “plane” in a manner that provides antecedent basis for the term.

The rejection of claim 17 is overcome by amending the dependency of the claim.

IV. THE ANTICIPATION REJECTION

The examiner rejected claims 1, 14 and 19 for being anticipated by Levailant et al. (USP 5,512,741).

The amendments to claim 1 above cause it to be novel over Levailant et al. For example, in amended claim 1, the scan is elliptic and the arrangement of the receiver elements is in the form of a sparse 2D array. This is not disclosed in any of the prior art of record. As a result, claim 1 and claims 14 and 19 which depend upon claim 1 are novel over Levailant et al.

V. THE OBVIOUSNESS REJECTION

Claims 1, 3-4, 9-10, 13 and 15-19 stand rejected for obviousness over the Appleby et al. article in view of Raber et al. (USP 4,791,427) and in view of EP 179687 (claim 4); in view of WO206945 and the Blommel et al. article (claims 11-12 or in view of USP 5,047,783 (claim 13). The examiner’s obviousness rejections are overcome by the extensive amendments made to independent claim 1 above.

Claim 1 is amended above to recite an elliptic, non circular, scanned millimeter wave imager wherein a sparse 2D array of receivers is employed. This claimed architecture is not disclosed or suggested in the prior art. The sparse array is provided by breaking the continuous block of elements up in a first axis by putting a gap between elements in the axis while maintaining a contiguous block of elements on a second orthogonal axis. The elliptical scan then acts to “fill in the gaps” along the first axis. These amendments cause independent claim 1 to be non-obvious over the cited prior art.

In addition, claim 1 is non-obvious because the Raber reference does not disclose a millimeter wave array as the examiner suggests. Instead, Raber discloses two millimeter wave horns, each designed for different detection purposes as described in column 3, lines 20-41. Claim 1 is non-obvious for this reason as well.

Dependent claims 3-4, 9-10, 13 and 15-19 are non-obvious and patentable at least by virtue of their dependence upon independent claim 1.

CONCLUSION

The application specification, figures and claims are believed to be ready for patenting for at least the reasons recited above. Favorable reconsideration and allowance of all pending application claims is courteously solicited.

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Appendix A

(Marked Up Specification Pages)

IMAGING APPARATUS

This invention relates to an imaging apparatus. More particularly, but not exclusively, it relates to a millimetre wave imaging apparatus.

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A current real-time passive millimetre wave imager 100, as shown in Figure 1, typically employs a mechanical scanning device 102 located behind a receiver array 104 to scan a wide field of view onto a focusing reflector 106. The receiver array 104 typically lies in the focal plane of the focusing reflector 106. Increasing the number of elements in an imager's receiver array allows the dwell time on each pixel of an image to be increased during a mechanical scan, thereby increasing the signal to noise ratio for each pixel and increasing image quality. However, due to physical size constraints upon the size of receiver array elements, such an increase in the number of elements causes beam obscuration, due to the geometry of the imager 100.

Another problem associated with current imaging apparatus is that it samples the field of view at a sub-Nyquist rate, typically at less than half Nyquist rate. This is particularly true with staring arrays in which there is no mechanical scanning of the field of view across the focal plane. Sub-Nyquist sampling leads to poor image quality. This is why scanning arrays have hitherto provided better quality images than staring arrays.

25 According to the present invention there is provided a millimetre wave imaging apparatus comprising scanning means, focusing means and a plurality of receiver elements, the focusing means being physically interposed between the scanning means and the receiver elements, the scanning means being arranged to scan radiation from a field of view onto said focusing means such that focussed radiation from a region of the field
30 of view is incident upon at least one of the plurality of receiver elements.

This architecture allows a large number of elements to be introduced into the focal plane, without causing beam obscuration for a large field of view, as the receiver elements do not lie in the path of radiation passing from the scanning means to the focusing means. This enables higher sensitivities to
5 be achieved than existing mechanical scanning passive millimetre wave imagers.

Additionally, this architecture allows Nyquist sampling and relative calibration to be achieved using a high-density receiver element array.
10 The scanning means may be two prisms. The prisms may be wedge prisms. The prisms may be of uniform thickness and varying refractive index across their respective cross-sections. Each of the prisms may be arranged to rotate. The prisms may be arranged to rotate in opposite directions to each other. The prisms may be arranged to produce an elliptical scan path
15 in the focal plane. The elliptical scan path may have a minor diameter that corresponds approximately to half the array spacing of the elements in an array. This ensures that Nyquist sampling is achieved in the direction of the array. It also results in adjacent elements sampling the same region of a scene alternately, which allows relative calibration of elements to be
20 employed.

The plurality of receiver elements may be arranged in a linear, or a curvilinear array. The prisms may be arranged to rotate at a rate of at least
25 revolutions per second.

The scanning means may be a prism. The prism may be a wedge prism. The prisms may be of uniform thickness and varying refractive index across a cross-section thereof. The prism may be arranged to rotate. The prism may be arranged to produce a circular scan path in the focal plane.
30 The plurality of receiver elements may be arranged in a sparse two dimensional, or a linear array.

An imaging apparatus with a single prism scanning means is cheaper and simpler to manufacture than a dual prism apparatus; as only a single prism and drive means need to be produced.

- 5 The focusing means may be a reflector lens. The reflector lens may comprise a first polarising element, typically a wire grid. The reflector lens may further comprise a polarisation altering element, for example a Ferrite or a Faraday plate, typically arranged to alter the polarisation of radiation incident thereupon by about 45° . The reflector lens may also
- 10 comprise a second polarising element, typically a wire grid, usually arranged to reflect radiation transmitted by the first polarising element. Typically, the radiation incident upon the second polarising element is polarised at 45° to that transmitted by the first polarising element.
- 15 Alternatively, the focusing means may be a refractive element or a diffractive element.

The scanning means, which may be arranged to define an entrance pupil of the apparatus, may be placed at the effective centre of curvature of the

20 focusing means.

The invention will now be described, by way of example only, with reference to the accompanying drawings, in which:

25 **Figure 1** is a millimetre wave imaging apparatus of the prior art;

Figure 2 is a schematic diagram of a first embodiment of an imaging apparatus according to the present invention;

30 **Figure 3** is a schematic diagram of a focusing arrangement of the imaging apparatus of Figure 2;

Figure 4 is a representation of an elliptical scan path produced by the imaging apparatus of Figure 2;

5 **Figure 4a** is a representation of elliptical scan paths incident upon three linear arrays;

Figure 5 is a schematic diagram of a second embodiment of an imaging apparatus according to the present invention; and

10 **Figure 6** is a circular scan path produced by the imaging apparatus of Figure 5.

Referring now to Figures 2 to 4a, a millimetre wave imaging apparatus 200 comprises a scanning mechanism 202, a focusing device 210 and a receiver
15 array 212.

The scanning mechanism 202 comprises first and second disc shaped wedge prisms 204, 205, typically a Risley prism, that are connected to respective drive mechanisms 206, 208. For small beam deviations, typically a few
20 degrees, a low loss wedge shaped piece of refractive index, such as polythene, can be used while for large beam deviations, typically ten degrees or more, a wedge of "Lettington reflector lens" can be used. A "Lettington reflector lens" comprises two linearly polarising grids, having a polarisation difference of 45° therebetween, that are separated by a sheet of
25 Faraday rotator that rotates the polarisation by 45° .

The prisms 204, 205 are connected to respective drive mechanisms 206, 208 such that they counter-rotate (in opposing directions) about their respective centres, typically at more than 25 Hz. The drive mechanisms
30 206, 208 are arranged to create an elliptical scan pattern. Such an elliptical scan pattern is sufficient to scan a number of linear arrays in the focal plane.

The focusing device 210 (essentially a reflector lens, also known as a Lettington lens) comprises a first grid 214 typically of metallic wires, typically either horizontally or vertically aligned, a polarisation altering
5 element 216, typically a meanderline structure, Ferrite or a Faraday plate, usually arranged to rotate the polarisation of incident radiation by 45° , and a second grid 218 usually of metallic wires, normally inclined at 45° , to the first grid 214. The scanning mechanism 202 is located optically at the radius of curvature of the first grid 214, by reflection in the grid 218. As
10 the scanner defines the entrance pupil of the imager this arrangement reduces optical aberrations of coma and astigmatism. Physically this means the scanning mechanism 202 is next to the curved grid 214. As the receiver array 212 needs to be in the focal plane of the focusing device 210, these devices are physically adjacent to each other. This means the scanning
15 mechanism 202, the focusing device 210 and the receiver array 212 are physically next to each other, which offers a very compact arrangement.

The receiver array 212 is made up of a plurality of radiometer receiver arrays 220a-e (shown extending into the plane of the paper), each array
20 typically comprising input feedhorns and detector elements. The receiver arrays 220a-e are typically linear or curvilinear and are composed of a plurality of receiver elements.

In use, radiation 222a incident upon the first rotating prism 204 is refracted
25 by an amount that is dependent upon the thickness of the prism 204 at the point at which the radiation 222a impinges upon the prism. As the prism 204 is of variable thickness and is rotating, radiation impinging upon the prism 204 at the same point in space will be subject to a degree of refraction that varies with time. This effect is also achievable by the use of
30 a rotating prism of constant thickness but varying refractive index.

Radiation 222b passes between the first prism 204 and the second prism 205 where it is refracted for a second time, again with a time varying magnitude due to the rotation of the second wedge prism 205.

- 5 Radiation 222c impinges upon the first grid 214 of the lens 210 where it is selectively linearly polarised orthogonal to the orientation of the grid 214 to produce radiation 222c'. The polarisation altering element 216 rotates the polarisation of the radiation 222c', typically by 45°, to produce radiation 222d. This radiation 222d is reflected by the second grid 218 such
10 that radiation 222e passes back through the polarisation altering element 216 and has its polarisation rotated further, usually by 45°. Radiation 222f now has a planar polarisation that is parallel to the wires of the first grid 214. This radiation is therefore reflected therefrom back through the polarisation altering element ~~214~~216 to produce radiation 222g that is
15 polarised perpendicularly the wires of the second grid 218 and can therefore pass through the second grid 218 and is focussed onto the receiver arrays 220a-e.

The result of such an optical arrangement is that a field of view 250 is
20 divided into a number of overlapping elliptical scan paths 252a-e. Scan path 252a is the part of the field of view that is projected, portion by portion, onto a single array element of the array 212 as the prisms 204, 205 rotate.

- 25 The minor diameter of the elliptical scan paths 252a-e are typically such that they correspond to half the spacing of linear elements 253a-h of an array 254a-c. This allows adjacent elements 253a-h of a linear array 254a-c to measure the same region of space, thus allowing relative calibration, which improves image quality. Such a sampling also allows Nyquist
30 sampling in the direction of the array 254a-c. This is because to achieve Nyquist sampling in a perfect array sampling is needed between the

elements. The only way this can be achieved is by mechanically scanning to sample between the feed locations, the elements. The major diameter of the scan paths 252a-e correspond to the distance between the arrays 254a-c. In this way all regions of space in the field of view are scanned.

- 5 Furthermore, with the major elliptical diameter corresponding to the array separation, array elements 253a-h of one linear array 254a measure the same region of the image as the adjacent array 254b once per revolution. This overlap can be used for relative calibration, which improves image quality.

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The major diameter of the scan paths 252a-e are typically such that regions between the linear arrays 220a-e can be sampled and the wedge angle of the prisms 204, 205 is such that there is overlap between the arrays 220a-e. The relative speed of rotation of the prisms 204, 205 within the imaging apparatus 200 that allows the formation of elliptical scan patterns. This allows Nyquist sampling in the direction perpendicular to the receiver arrays 220a-e and also allows relative calibration of array elements between the receiver arrays 220a-e.

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- 20 Referring now to Figures 5 and 6, an imaging apparatus 500 comprises a wedge prism 502, a drive mechanism 504 for rotating the prism 502, a reflector lens 506 and a receiver array 508.

- The reflector lens 506 comprises a first grid 510, typically of wires, a
25 polarisation altering element 512, typically a meanderline, Ferrite or Faraday plate, usually arranged to rotate the polarisation of incident radiation by 45°, and a second grid 514. The reflector lens 506 operates substantially as hereinbefore described with reference to the reflector lens 110 of Figure 1.

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Radiation 516 incident upon the prism 502 undergoes a time varying
magnitude of refraction such that upon passing through the reflector lens

506 a circular scan path 550 is traced in a focal plane of the imaging apparatus 500.

Typical receiver array 508 configurations for such an optical arrangement
5 include linear and two-dimensional sparse arrays.